

Vishay Siliconix

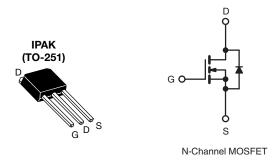
COMPLIANT

HALOGEN

FREE

## **D Series Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V) at T <sub>J</sub> max.	T <sub>J</sub> max. 550				
R <sub>DS(on)</sub> max. (Ω) at 25 °C	V <sub>GS</sub> = 10 V	3.2			
Q <sub>g</sub> (max.) (nC)	20				
Q <sub>gs</sub> (nC)	3				
Q <sub>gd</sub> (nC)	5				
Configuration	Single				



#### **FEATURES**

- Optimal Design
  - Low Area Specific On-Resistance
  - Low Input Capacitance (Ciss)
  - Reduced Capacitive Switching Losses
  - High Body Diode Ruggedness
  - Avalanche Energy Rated (UIS)
- Optimal Efficiency and Operation
  - Low Cost
  - Simple Gate Drive Circuitry
  - Low Figure-of-Merit (FOM): Ron x Qg
  - Fast Switching
- Material categorization: For definitions of compliance please see <a href="https://www.vishay.com/doc?99912"><u>www.vishay.com/doc?99912</u></a>

### **APPLICATIONS**

- Consumer Electronics
  - Displays (LCD or Plasma TV)
- Server and Telecom Power Supplies
  - SMPS
- Industrial
  - Welding
  - Induction Heating
  - Motor Drives
- Battery Chargers

ORDERING INFORMATION				
Package	IPAK (TO-251)			
Lead (Pb)-free	SiHU3N50D-E3			
Lead (Pb)-free and Halogen-free	SiHU3N50D-GE3			

PARAMETER				SYMBOL	LIMIT	UNIT
Drain-Source Voltage				$V_{DS}$	500	
Gate-Source Voltage				.,	± 30	V
Gate-Source Voltage AC (f > 1 Hz)				$V_{GS}$	30	
Continuous Drain Current (T <sub>J</sub> = 150 °C)		Vac at 10 V	T <sub>C</sub> = 25 °C		3.0	
			T <sub>C</sub> = 100 °C	l <sub>D</sub>	1.9	Α
Pulsed Drain Current <sup>a</sup>				I <sub>DM</sub>	5.5	
Linear Derating Factor				0.56	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>				E <sub>AS</sub>	9	mJ
Maximum Power Dissipation				$P_{D}$	104	W
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Drain-Source Voltage Slope T <sub>J</sub> = 125 °C		dV/dt	24	V/ns		
Reverse Diode dV/dt (d)			0.22	7 7/115		
Soldering Recommendations (Peak Temperature) <sup>c</sup> for 10 s				300	°C	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 2.3 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 2.8 A.
- c. 1.6 mm from case.
- d.  $I_{SD} \le I_D$ , starting  $T_J = 25$  °C.



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THERMAL RESISTANCE RATINGS					
PARAMETER SYMBOL TYP. MAX. UNIT					
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62	°C/W	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	1.8	G/ <b>VV</b>	

<b>SPECIFICATIONS</b> ( $T_J = 25$ °C, u	nless otherw	ise noted)					
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					•	•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 250 μA	-	0.56	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3	-	5	V
Gate-Source Leakage	I <sub>GSS</sub>	,	$V_{GS} = \pm 30 \text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		= 500 V, V <sub>GS</sub> = 0 V V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	1 10	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}$	I <sub>D</sub> = 2.5 A	_	2.6	3.2	Ω
Forward Transconductance <sup>a</sup>	9fs		= 8 V, I <sub>D</sub> = 1.5 A	_	1	-	S
Dynamic	313		, , ,	<u> </u>	1	1	
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,	-	175	-	
Output Capacitance	C <sub>oss</sub>	╡ ,	$V_{GS} = 0 \text{ V},$ $V_{DS} = 100 \text{ V},$	-	21	-	1
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1 MHz		_	5	-	1
Effective Output Capacitance, Energy Related <sup>b</sup>	C <sub>o(er)</sub>	$V_{DS} = 0 V \text{ to } 400 V, V_{GS} = 0 V$		-	21	-	pF
Effective Output Capacitance, Time Related <sup>c</sup>	C <sub>o(tr)</sub>			-	26	-	
Total Gate Charge	Qg			-	6	12	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$ $I_D = 1.5 \text{ A}, V_{DS} = 400 \text{ V}$		-	2	-	nC
Gate-Drain Charge	Q <sub>gd</sub>			-	3	-	1
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 400 V, I <sub>D</sub> = 1.5 A		-	12	24	
Rise Time	t <sub>r</sub>			-	9	18	1 _
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g =$	9.1 $\Omega$ , $V_{GS} = 10 \text{ V}$	-	11	22	ns
Fall Time	t <sub>f</sub>			-	13	26	
Gate Input Resistance	$R_g$	f = 1 MHz, open drain		-	3.3	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse P - N junction diode		-	-	3	
Pulsed Diode Forward Current	I <sub>SM</sub>			-	-	12	A
Diode Forward Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 1.5 A, V <sub>GS</sub> = 0 V		-	-	1.2	٧
Reverse Recovery Time	t <sub>rr</sub>	_		-	293	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25 ^{\circ}\text{C}$ , $I_F = I_S = 1.5 \text{A}$ , $I_F = 1.5 ^{\circ}\text{C}$ , $I_F = 1.5 ^{\circ}\text{C}$		-	0.74	-	μC
Reverse Recovery Current	I <sub>RRM</sub>			-	5	-	Α

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . c.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

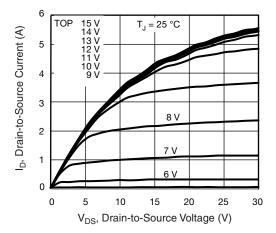


Fig. 1 - Typical Output Characteristics

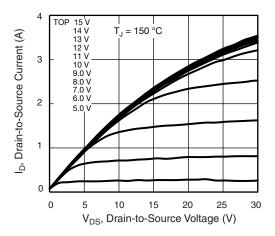


Fig. 2 - Typical Output Characteristics

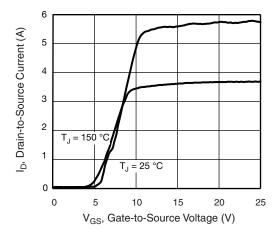


Fig. 3 - Typical Transfer Characteristics

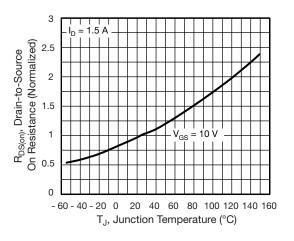


Fig. 4 - Normalized On-Resistance vs. Temperature

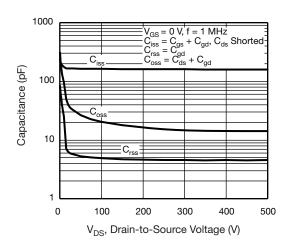


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

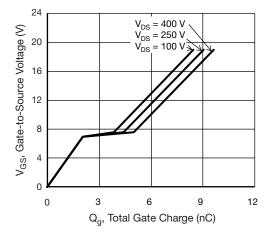


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



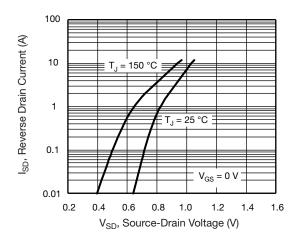


Fig. 7 - Typical Source-Drain Diode Forward Voltage

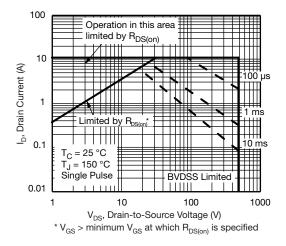


Fig. 8 - Maximum Safe Operating Area

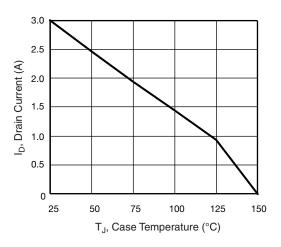


Fig. 9 - Maximum Drain Current vs. Case Temperature

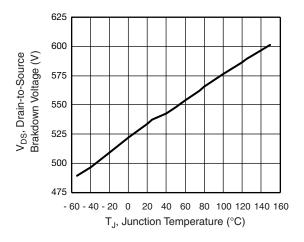


Fig. 10 - Typical Drain-to-Source Voltage vs. Temperature

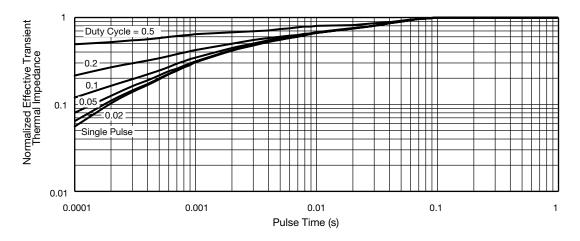


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



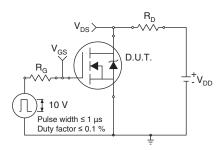


Fig. 12 - Switching Time Test Circuit

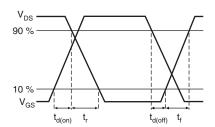


Fig. 13 - Switching Time Waveforms

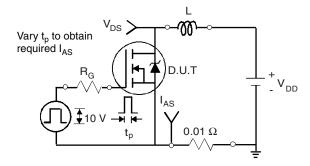


Fig. 14 - Unclamped Inductive Test Circuit

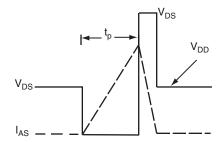


Fig. 15 - Unclamped Inductive Waveforms

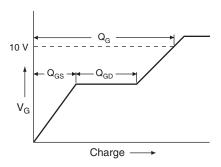


Fig. 16 - Basic Gate Charge Waveform

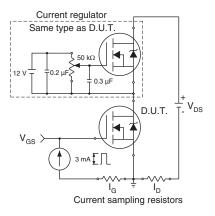
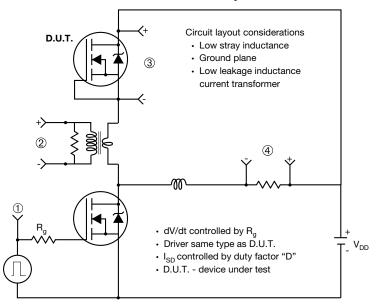


Fig. 17 - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



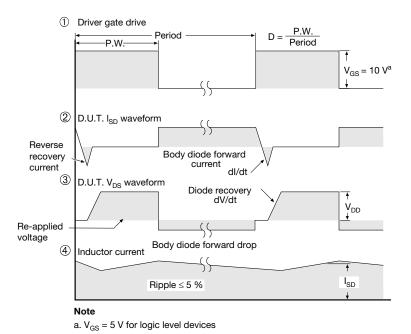
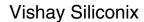


Fig. 18 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg?91493">www.vishay.com/ppg?91493</a>.





## **TO-251AA (HIGH VOLTAGE)**



Section B - B and C - C

	MILLIN	METERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	2.18	2.39	0.086	0.094
A1	0.89	1.14	0.035	0.045
b	0.64	0.89	0.025	0.035
b1	0.65	0.79	0.026	0.031
b2	0.76	1.14	0.030	0.045
b3	0.76	1.04	0.030	0.041
b4	4.95	5.46	0.195	0.215
С	0.46	0.61	0.018	0.024
c1	0.41	0.56	0.016	0.022
c2	0.46	0.86	0.018	0.034
D	5.97	6.22	0.235	0.245

	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
D1	5.21	-	0.205	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
е	2.29	2.29 BSC		2.29 BSC	
L	8.89	9.65	0.350	0.380	
L1	1.91	2.29	0.075	0.090	
L2	0.89	1.27	0.035	0.050	
L3	1.14	1.52	0.045	0.060	
θ1	0'	15'	0'	15'	
θ2	25'	35'	25'	35'	

ECN: S-82111-Rev. A, 15-Sep-08

DWG: 5968

#### Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimension are shown in inches and millimeters.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.13 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions b4, L2, E1 and D1.
- 5. Lead dimension uncontrolled in L3.
- 6. Dimension b1, b3 and c1 apply to base metal only.
- 7. Outline conforms to JEDEC outline TO-251AA.

Document Number: 91362 Revision: 15-Sep-08



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Vishay

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Please note that some Vishay documentation may still make reference to RoHS Directive 2002/95/EC. We confirm that all the products identified as being compliant to Directive 2002/95/EC conform to Directive 2011/65/EU.

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Revision: 02-Oct-12 Document Number: 91000